

1.Description

The AO4606 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

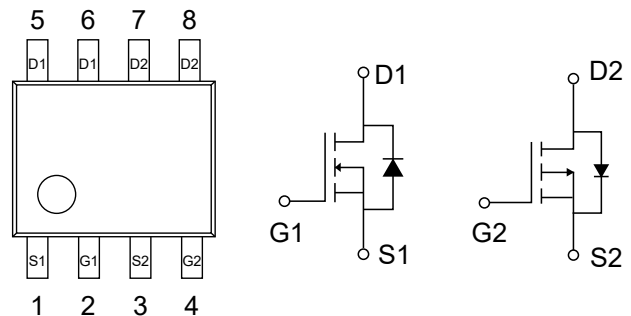
2.Features

- $V_{DS(V)}=30V$
- $I_D=6A$
- $R_{DS(ON)}<28m\Omega(V_{GS}=10V)$
- $R_{DS(ON)}<42m\Omega(V_{GS}=4.5V)$
- $V_{DS(V)}=-30V$
- $I_D=-7.6A$
- $R_{DS(ON)}<32m\Omega(V_{GS}=10V)$
- $R_{DS(ON)}<40m\Omega(V_{GS}=4.5V)$

3.Pinning information

Pin	Symbol	Description
2,4	G1, G2	GATE
1,3	S1, S2	SOURCE
5,6,7,8	D1, D2	DRAIN

SOP-8



4.Absolute Maximum Ratings $T_A=25^{\circ}C$

Parameter		Symbol	Rating		Units
			N-Ch	P-Ch	
Drain-Source Voltage		V_{DS}	30	-30	V
Gate-Source Voltage		V_{GS}	± 20	± 20	V
Continuous Drain Current, $V_{GS}=10V$ ¹	$T_C=25^{\circ}C$	I_D	6	-7.6	A
Continuous Drain Current, $V_{GS}=10V$ ¹	$T_C=100^{\circ}C$		4.5	-5.9	A
Pulsed Drain Current ²		I_{DM}	20	-15	A
Single Pulse Avalanche Energy ³		E_{AS}	22	45	mJ
Avalanche Current		I_{AS}	21	-30	A
Total Power Dissipation ⁴	$T_C=25^{\circ}C$	P_D	2	2	W



Storage Temperature Range	T_{STG}	-55 to 150	-55 to 150	°C
Operating Junction Temperature Range	T_J	-55 to 150	-55 to 150	°C
Thermal Resistance Junction-Ambient ¹	$R_{\theta JA}$		62	°C/W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$		5	°C/W



5.1 Electrical Characteristic (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	30			V
BV _{DSS} Temperature Coefficient	ΔBV _{DSS} /ΔT _J	Reference to 25°C, I _D =1mA		0.023		V/°C
Static Drain-Source On-Resistance ²	R _{DS(ON)}	V _{GS} =10V, I _D =6A		19	28	mΩ
		V _{GS} =4.5V, I _D =5A		28	42	mΩ
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1	1.7	2.5	V
V _{GS(th)} Temperature Coefficient	V _{GS(th)}			-5.2		mV/°C
Drain-Source Leakage Current	I _{DSS}	V _{DS} =24V, V _{GS} =0V, T _J =25°C			1	μA
		V _{DS} =24V, V _{GS} =0V, T _J =55°C			5	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Forward Transconductance	g _{FS}	V _{DS} =5V, I _D =5A		16		S
Gate Resistance	R _g	V _{GS} =0V, V _{DS} =0V, f=1MHz		2.5	5	Ω
Total Gate Charge (4.5V)	Q _g	V _{DS} =20V, V _{GS} =4.5V, I _D =5A		7.2		nC
Gate-Source Charge	Q _{gs}			1.4		nC
Gate-Drain Charge	Q _{gd}			2.2		nC
Turn-On Delay Time	t _{D(on)}	V _{DD} =15V, V _{GS} =10V R _G =3.3Ω, I _D =5A		4.1		ns
Rise Time	t _r			9.8		ns
Turn-Off Delay Time	t _{D(off)}			15.5		ns
Fall Time	t _f			6		ns
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1MHz		572		pF
Output Capacitance	C _{oss}			81		pF
Reverse Transfer Capacitance	C _{rss}			65		pF
Continuous Source Current ^{1,5}	I _S	V _G =V _D =0V, Force Current			10	A
Pulsed Source Current ^{2,5}	I _{SM}				20	A
Diode Forward Voltage ²	V _{SD}	V _{GS} =0V, I _S =1A, T _J =25°C			1.2	V

1. The data tested by surface mounted on a 1 inch ² FR-4 board with 20Z copper.

2. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%

3. The EAS data shows Max. rating. The test condition is V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=21A

4. The power dissipation is limited by 150°C junction temperature

5. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



5.2 Electrical Characteristic ($T_J=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=-250\mu\text{A}$, $V_{GS}=0\text{V}$	-30			V
BV_{DSS} Temperature Coefficient	$\Delta BV_{DSS}/\Delta T_J$	Reference to 25°C , $I_D=1\text{mA}$		-0.021		$\text{V}/^\circ\text{C}$
Static Drain-Source On-Resistance ²	$R_{DS(ON)}$	$V_{GS}=-10\text{V}$, $I_D=-7\text{A}$		24	32	$\text{m}\Omega$
		$V_{GS}=-4.5\text{V}$, $I_D=-5\text{A}$		32	40	$\text{m}\Omega$
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$	-1	-1.6	-2.5	V
$V_{GS(th)}$ Temperature Coefficient	$V_{GS(th)}$			-4.2		$\text{mV}/^\circ\text{C}$
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$, $T_J=25^\circ\text{C}$			-1	μA
		$V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$, $T_J=55^\circ\text{C}$			-5	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20\text{V}$, $V_{DS}=0\text{V}$			± 100	nA
Forward Transconductance	g_{FS}	$V_{DS}=-5\text{V}$, $I_D=-7\text{A}$		15		S
Gate Resistance	R_g	$V_{GS}=0\text{V}$, $V_{DS}=0\text{V}$, $f=1\text{MHz}$		15	30	Ω
Total Gate Charge (-4.5V)	Q_g	$V_{DS}=-20\text{V}$ $V_{GS}=-4.5\text{V}$ $I_D=-7\text{A}$		9.8		nC
Gate-Source Charge	Q_{gs}			2.2		nC
Gate-Drain Charge	Q_{gd}			3.4		nC
Turn-On Delay Time	$t_{D(on)}$	$V_{DD}=-15\text{V}$, $V_{GS}=-10\text{V}$ $R_G=3.3\Omega$, $I_D=-5\text{A}$		16.4		ns
Rise Time	t_r			20.2		ns
Turn-Off Delay Time	$t_{D(off)}$			55		ns
Fall Time	t_f			10		ns
Input Capacitance	C_{iss}	$V_{DS}=-15\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$		930		pF
Output Capacitance	C_{oss}			148		pF
Reverse Transfer Capacitance	C_{rss}			115		pF
Continuous Source Current ^{1,5}	I_S	$V_G=V_D=0\text{V}$, Force Current			-7.6	A
Pulsed Source Current ^{2,5}	I_{SM}				-15	A
Diode Forward Voltage ²	V_{SD}	$V_{GS}=0\text{V}$, $I_S=-1\text{A}$, $T_J=25^\circ\text{C}$			-1.2	V

1. The data tested by surface mounted on a 1 inch ² FR-4 board with 2OZ copper.

2. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

3. The EAS data shows. The power dissipation is limited by Max. rating.

4. The test condition is $V_{150^\circ\text{C}}$ junction temperature $V_{DD}=-25\text{V}$, $V_{GS}=-10\text{V}$, $L=0.1\text{mH}$, $I_{AS}=-30\text{A}$.

5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



7.1 Typical characteristic

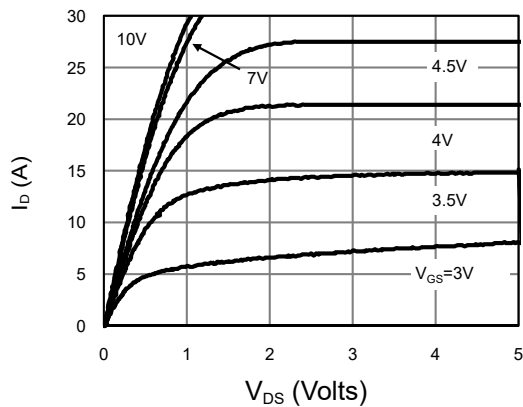


Fig.1 On-Region Characteristics

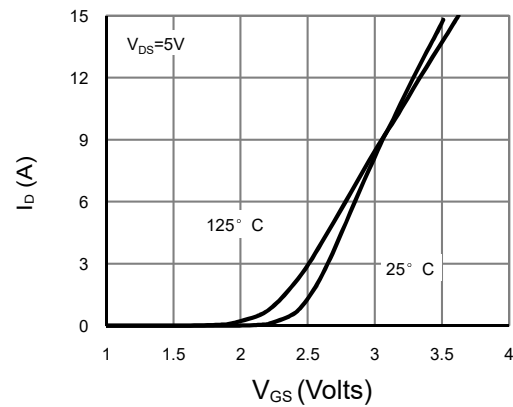


Fig.2 Transfer Characteristics

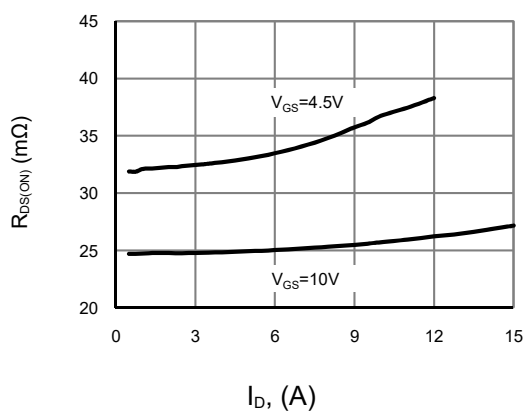


Fig.3 On-Resistance vs. Drain Current and Gate Voltage

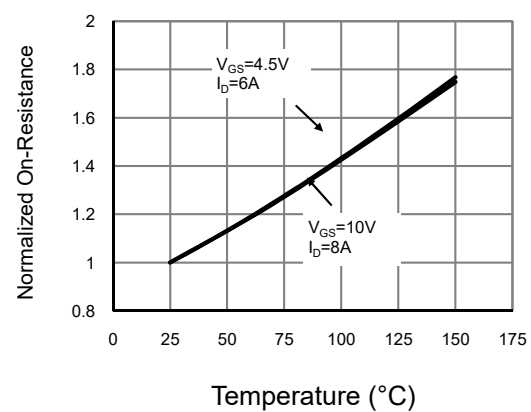


Fig.4 On-Resistance vs. Junction Temperature

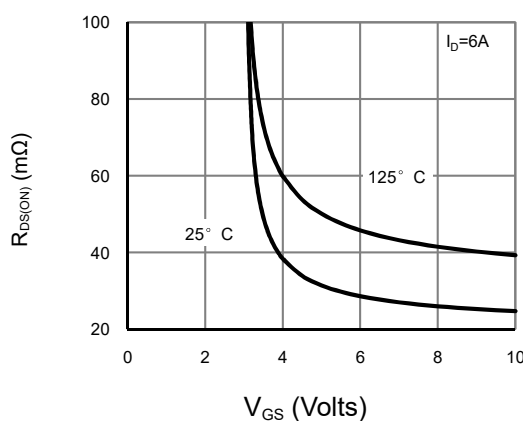


Fig.5 On-Resistance vs. Gate-Source Voltage

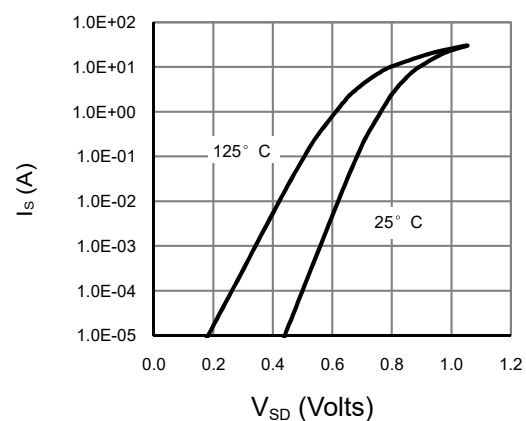


Fig.6 Body-Diode Characteristics



7.2 Typical characteristic

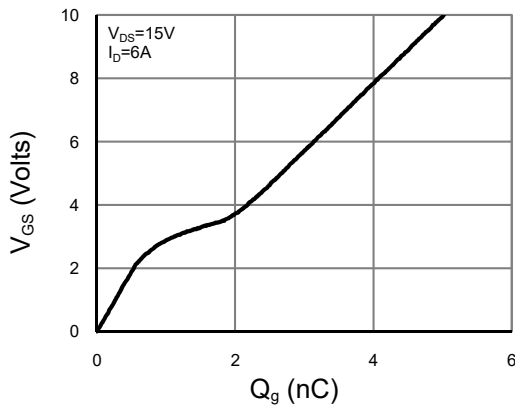


Fig.7 Gate-Charge Characteristics

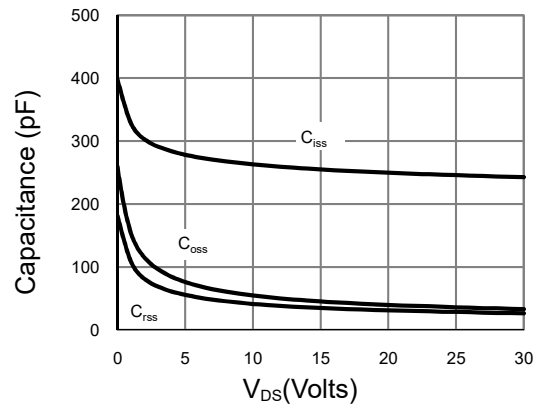


Fig.8 Capacitance Characteristics

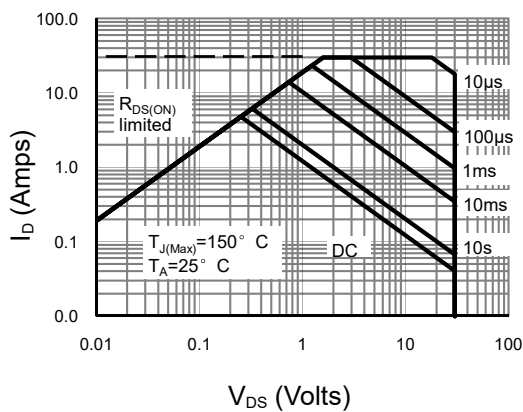


Fig.9 Maximum Forward Biased Safe Operating Area

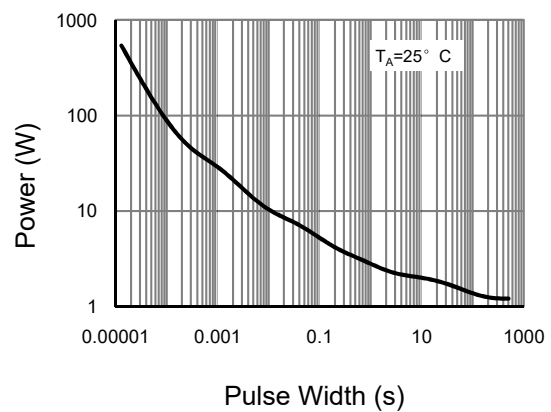


Fig.10 Single Pulse Power Rating Junction-to-Ambient

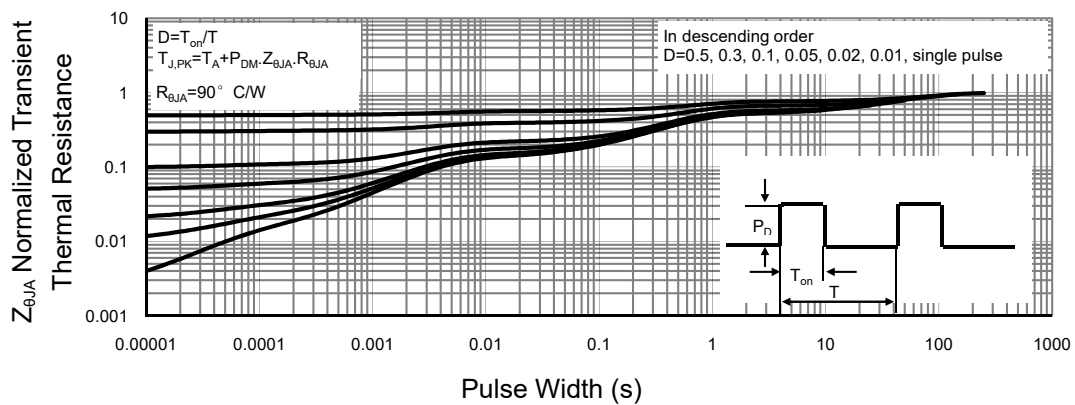


Fig.11 Normalized Maximum Transient Thermal Impedance

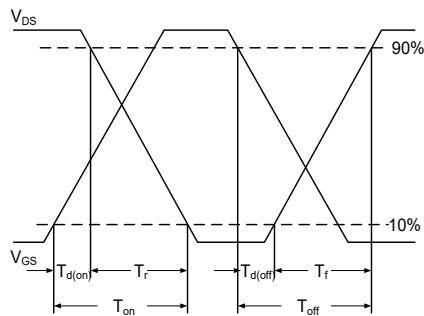


Fig.12 Switching Time Waveform

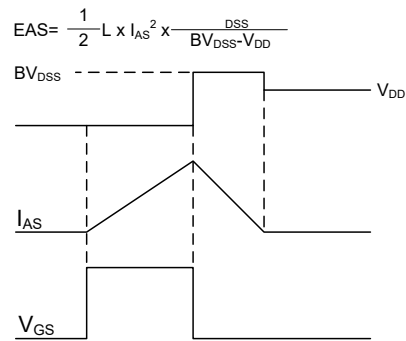


Fig.13 Unclamped Inductive Switching Waveform



7.3 Typical characteristic

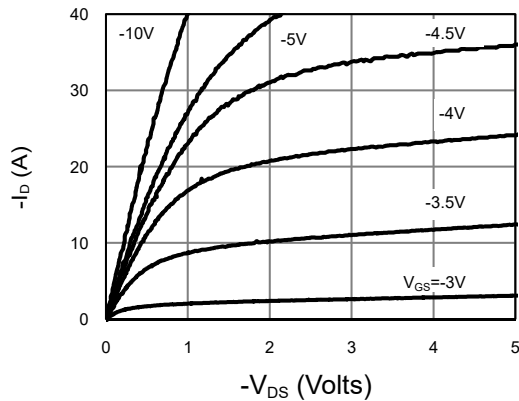


Fig. 14 On-Region Characteristics

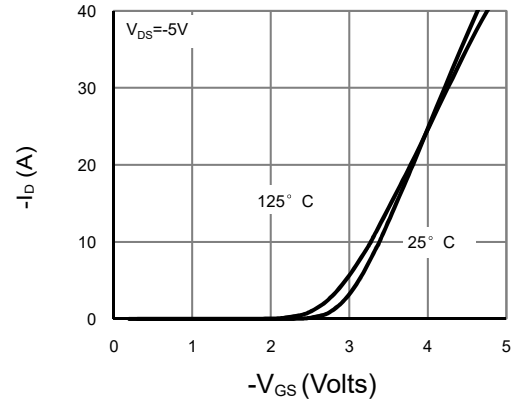


Fig. 15 Transfer Characteristics

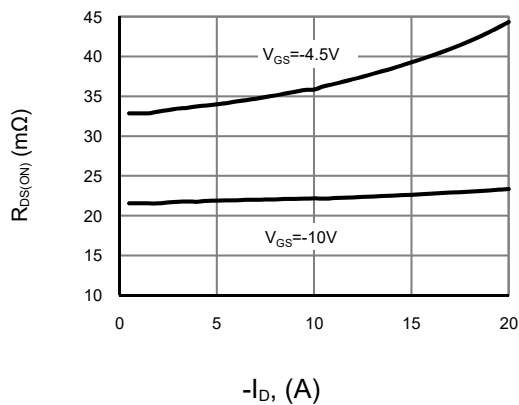


Fig. 16 On-Resistance vs. Drain Current and Gate Voltage

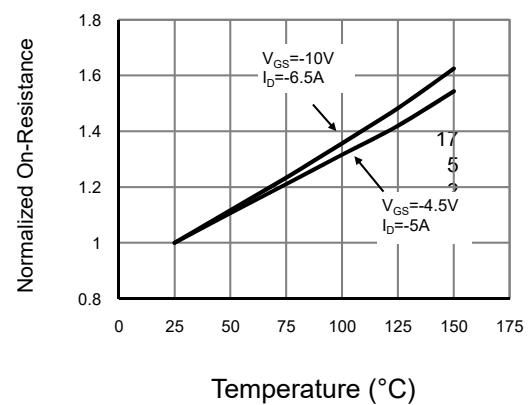


Fig. 17 On-Resistance vs. Junction Temperature

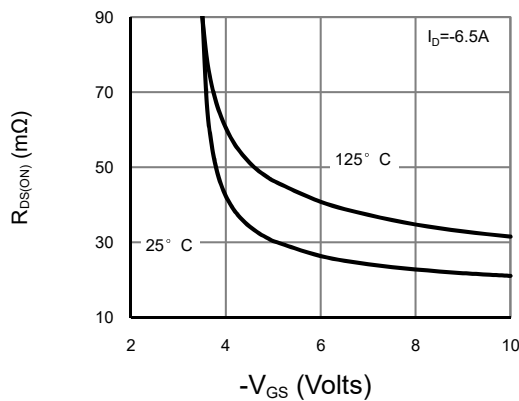


Fig. 18 On-Resistance vs. Gate-Source Voltage

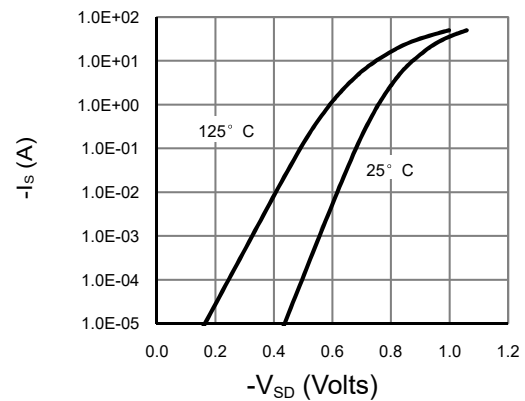


Fig. 19 Body-Diode Characteristics



7.4 Typical characteristic

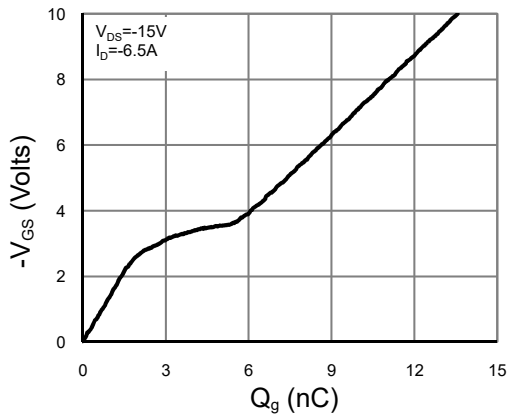


Fig.20 Gate-Charge Characteristics

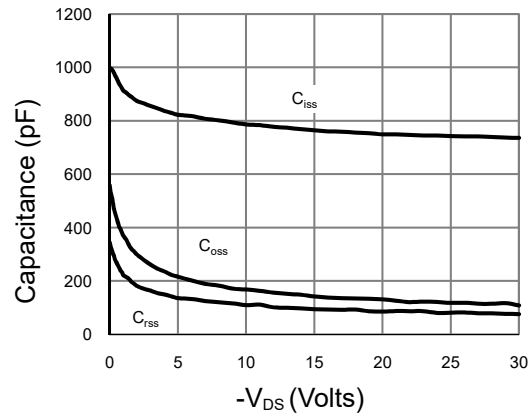


Fig.21 Capacitance Characteristics

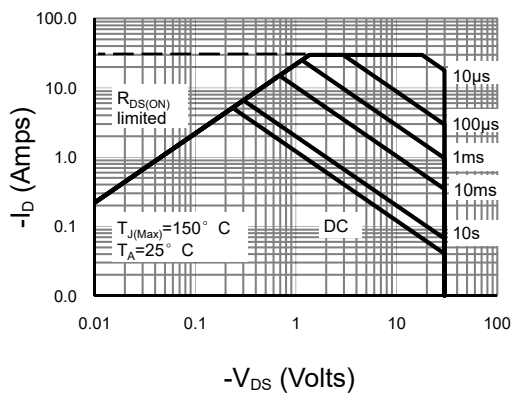


Fig.22 Maximum Forward Biased Safe Operating Area

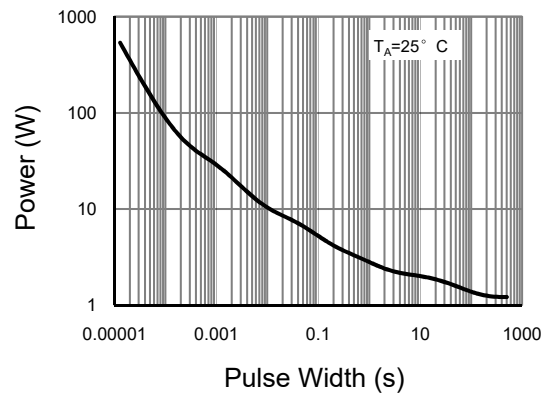


Fig.23 Single Pulse Power Rating Junction-to-Ambient

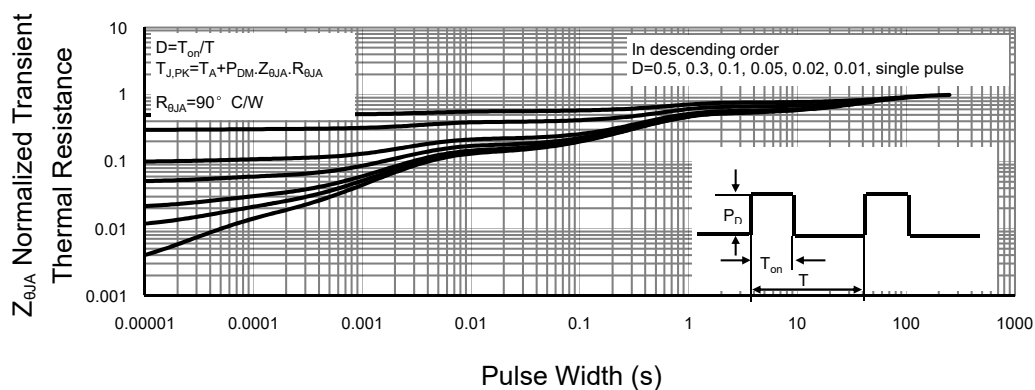


Fig.24 Normalized Maximum Transient Thermal Impedance

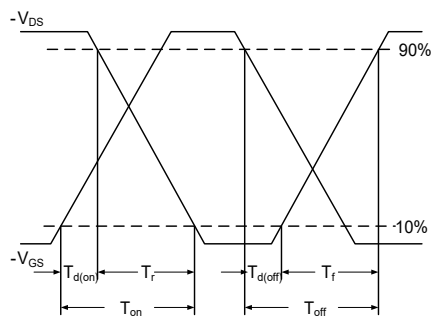


Fig.25 Switching Time Waveform

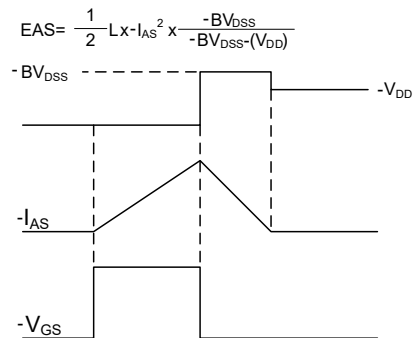
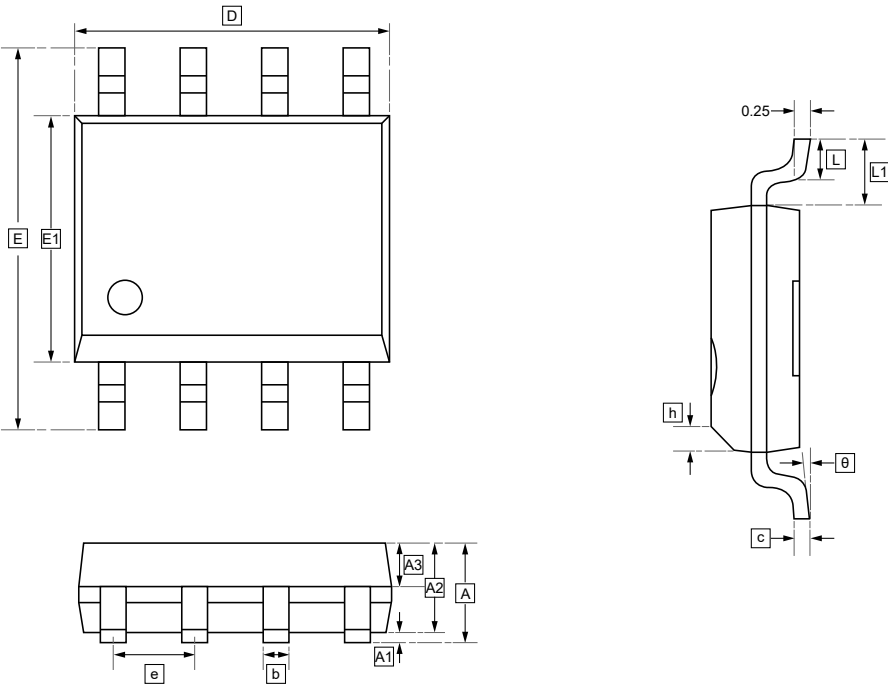


Fig.26 Unclamped Inductive Switching Waveform



8.SOP-8 Package Outline Dimensions



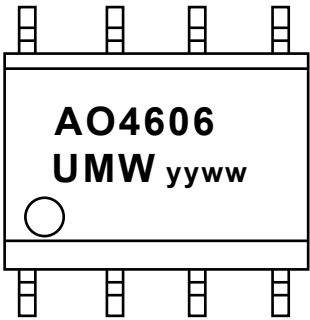
DIMENSIONS (mm are the original dimensions)

Symbol	A	A1	A2	A3	b	c	D	E	E1	e	h	L
Min	-	0.05	1.30	0.60	0.39	0.20	4.80	5.80	3.80	1.24	0.30	0.50
Max	1.75	0.20	1.50	0.70	0.47	0.24	5.00	6.20	4.00	1.30	0.50	0.80

Symbol	L1	θ
Min	1.00	0°
Max	1.10	8°



9.Ordering information



yy: Year Code
ww: Week Code

Order Code	Package	Base QTY	Delivery Mode
UMW AO4606	SOP-8	3000	Tape and reel



10.Disclaimer

UMW reserves the right to make changes to all products, specifications. Customers should obtain the latest version of product documentation and verify the completeness and currency of the information before placing an order.

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